TICP106 SERIES SILICON CONTROLLED RECTIFIERS

BOURNS®

- 2 A Continuous On-State Current
- 15 A Surge-Current
- Glass Passivated Wafer
- 400 V to 600 V Off-State Voltage
- Max I_{GT} of 200 μA
- Package Options

PACKAGE	PACKING	PART # SUFFIX		
LP	Bulk	(None)		
LP with fomed leads	Tape and Reel	R		



MDC1AA



MDC1AB

absolute maximum ratings over operating case temperature (unless otherwise noted)

RATING	SYMBOL	VALUE	UNIT	
Benetitive peak off-state voltage (see Note 1)	V	400	V	
TICP106M	¥ DRM	600		
Penetitive peak reverse veltage	V	400	V	
TICP106M	¥ RRM	600		
Continuous on-state current at (or below) 25°C case temperature (see Note 2)	I _{T(RMS)}	2	Α	
Surge on-state current (see Note 3)	I _{TSM}	15	А	
Peak positive gate current (pulse width ≤ 300 µs)	I _{GM}	0.2	А	
Average gate power dissipation (see Note 4)	P _{G(AV)}	0.3	W	
Operating case temperature range	т _с	-40 to +110	°C	
Storage temperature range	T _{stg}	-40 to +125	°C	
Lead temperature 3.2 mm from case for 10 seconds	ΤL	230	°C	

NOTES: 1. These values apply when the gate-cathode resistance R_{GK} = 1 k\Omega.

2. These values apply for continuous dc operation with resistive load. Above 25°C derate linearly to zero at 110°C.

3. This value applies for one 50 Hz half-sine-wave when the device is operating at (or below) the rated value of peak reverse voltage and on-state current. Surge may be repeated after the device has returned to original thermal equilibrium.

4. This value applies for a maximum averaging time of 20 ms.

PRODUCT INFORMATION

TICP106 SERIES SILICON CONTROLLED RECTIFIERS



electrical characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	ТҮР	MAX	UNIT
I _{DRM}	Repetitive peak off-state current	$V_D = rated V_{DRM}$	$R_{GK} = 1 \ k\Omega$				20	μA
I _{RRM}	Repetitive peak reverse current	V_{R} = rated V_{RRM}	I _G = 0				200	μΑ
I _{GT}	Gate trigger current	V _{AA} = 12 V	$R_L = 100 \Omega$	t _{p(g)} ≥ 20 μs		5	200	μA
V _{GT}	Gate trigger voltage	V _{AA} = 12 V	R _L = 100 Ω R _{GK} = 1 kΩ	$t_{p(g)} \geq 20 \ \mu s$	0.4		1	V
Ч _Н	Holding current	V _{AA} = 12 V	R _{GK} = 1 kΩ	Initiating I _T = 10 mA			5	mA
V _T	On-state voltage	I _T = 1 A	(see Note 5)				1.5	V

NOTE 5: This parameter must be measured using pulse techniques, $t_p = 1$ ms, duty cycle ≤ 2 %. Voltage sensing-contacts, separate from the current carrying contacts, are located within 3.2 mm from the device body.



